



SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT BY APPLICANT PTO-1449	DOCKET NO. 52433/789	SERIAL NO. 10/527,809
	APPLICANT Hiroshi ICHIKAWA et al.	
	FILING DATE November 09, 2005	GROUP 1742

U. S. PATENT DOCUMENTS

EXAMINER INITIAL	PATENT/PUBLICATION NUMBER	PATENT/PUBLICATION DATE	NAME	CLASS	SUBCLASS	FILING DATE

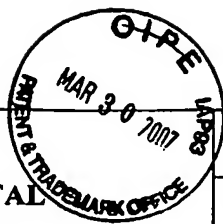
FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						Yes	No
<i>K</i>	JP 2002-194452	July 10, 2002	Japan				X
<i>R</i>	JP 50-101202	August 11, 1975	Japan				X

OTHER DOCUMENTS

EXAMINER INITIAL	AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.

EXAMINER <i>[Signature]</i>	DATE CONSIDERED 8/29/07
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EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						Yes	No
<i>h</i>	CN 1345380 A	April 17, 2002	China				X

OTHER DOCUMENTS

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8/30/07

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March 11, 2005

GROUP 1.742
Not Yet Assigned

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EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						Yes	No
	JP 2002-194452 A	July 10, 2002	Japan			Abstract	
<i>h</i>	JP 53-29122 B2	August 18, 1978	Japan			Abstract	
<i>h</i>	JP 2001-294942 A	October 26, 2001	Japan			Abstract	
<i>ch</i>	JP 10-265861 A	October 6, 1998	Japan			Abstract	
<i>h</i>	JP 55-104434 A	August 9, 1980	Japan			Abstract	

OTHER DOCUMENTS

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